

BAV23S

HIGH VOLTAGE GENERAL PURPOSE DIODE

P_D350 mW @ T_A = 25 Deg C
B_V250 V (MIN) @ I_R = 100 uA
T_{RR} . . . 50 nS @ I_F=I_R = 30 mA I_{RR} = 3.0 mA

ABSOLUTE MAXIMUM RATINGS (NOTE 1)

TEMPERATURES

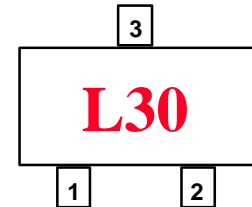
Storage Temperature 150 Degrees C
 Operating Junction Temperature 150 Degrees C

POWER DISSIPATION (NOTES 2 & 3)

Total Device Dissipation at T_A = 25 Deg C 350 mW
 Derating Factor per Degree C 2.8 mW

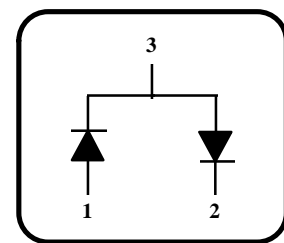
VOLTAGES & CURRENTS

| | | |
|------------------------|---|--------|
| V _{RRM} | Repetitive Peak Reverse Voltage (Single Device) | 250 V |
| V _{RRM} | Repetitive Peak Reverse Voltage (Series Connection) | 500 V |
| V _{RWM} | Continuous Peak Reverse Voltage (Single Device) | 200 V |
| V _{RWM} | Continuous Peak Reverse Voltage (Series Connection) | 400 V |
| I _O | Average Rectified Current | 200 mA |
| I _F | DC Forward Current | 400 mA |
| i _f | Recurrent Peak Forward Current | 700 mA |
| i _f (surge) | Peak Forward Surge Current | |
| | Pulse Width = 1.0 microsec | 9.0 A |
| | Pulse Width = 100 microsec | 3.0 A |
| | Pulse Width = 10 millisec | 1.7 A |



PACKAGE
TO-236AB (Low)
(SOT-23)

CONNECTION DIAGRAMS

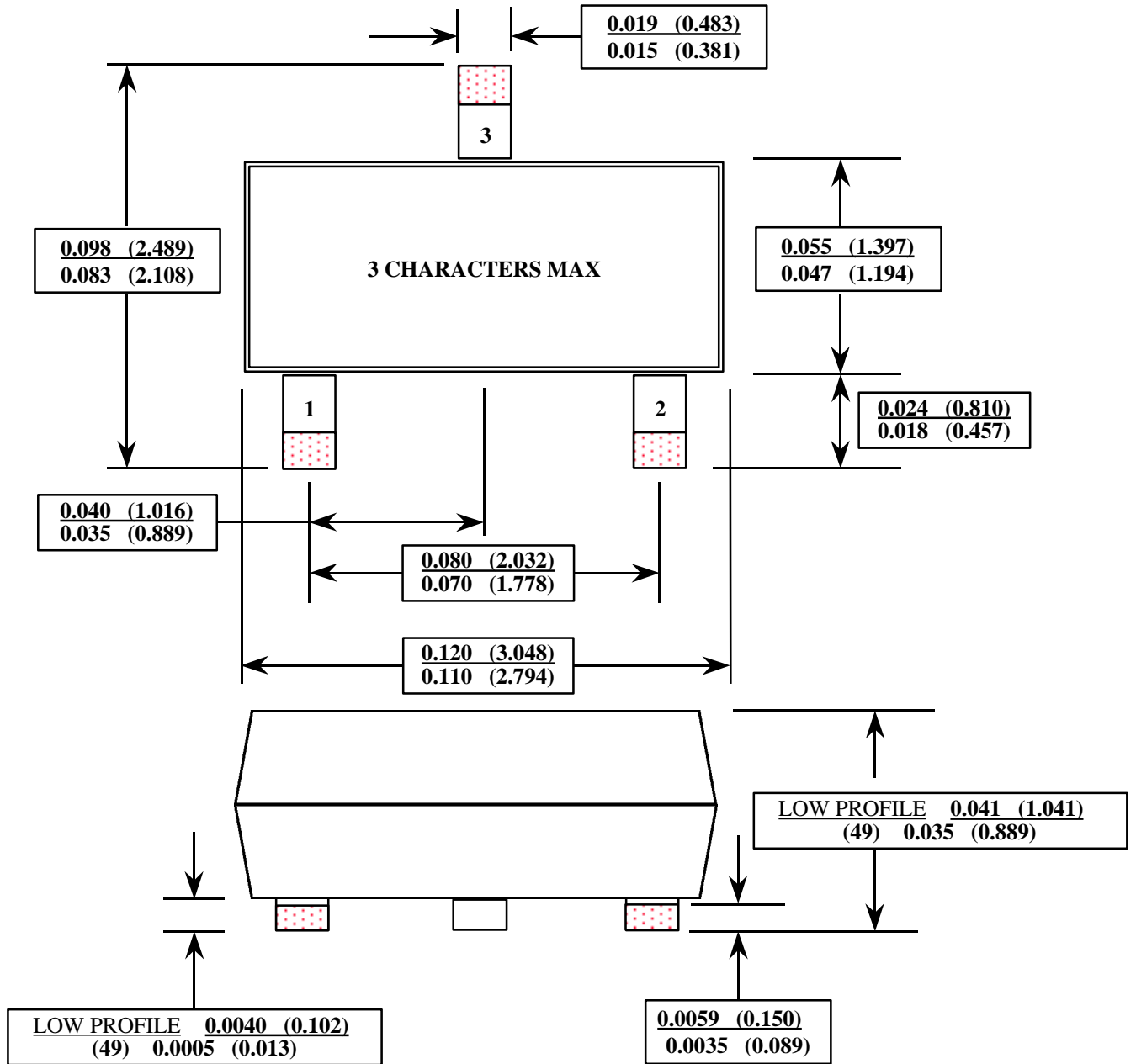


ELECTRICAL CHARACTERISTICS (25 Degrees C Ambient Temperature unless otherwise stated)

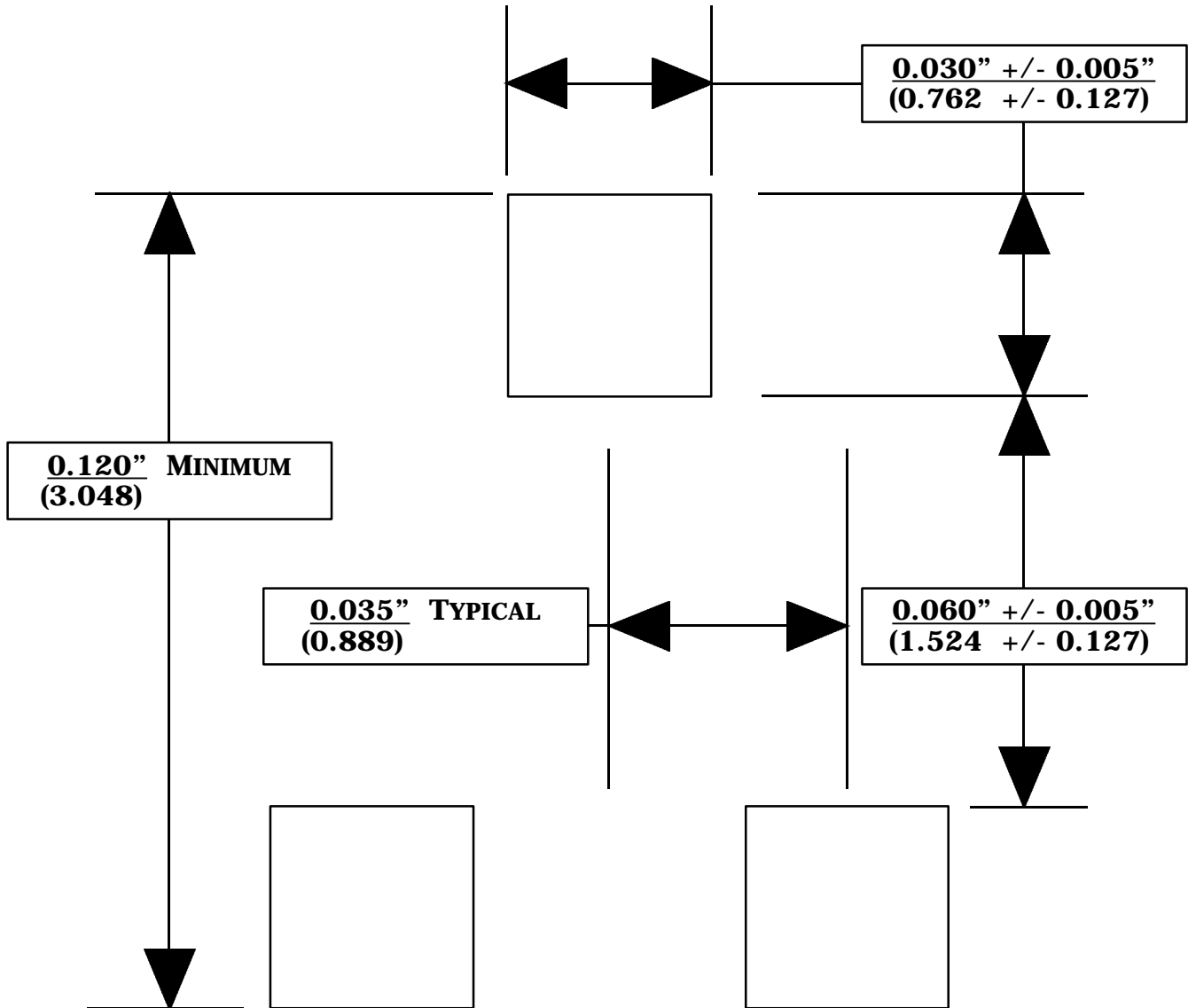
| SYM | CHARACTERISTICS | MIN | MAX | UNITS | TEST CONDITIONS |
|-----------------|-------------------------------------|-----|------|-------|---|
| B _V | Breakdown Voltage | 250 | | V | I _R = 100 uA |
| I _R | Reverse Current (single device) | | 100 | nA | V _R = 200 V |
| | | | 100 | uA | V _R = 200 V T _A = +150 Deg C |
| | Reverse Current (series connection) | | 100 | nA | V _R = 400 V |
| | | | 100 | uA | V _R = 400 V T _A = +150 Deg C |
| V _F | Forward Voltage (single device) | | 1.00 | V | I _F = 100 mA |
| | | | 1.25 | V | I _F = 200 mA |
| | Forward Voltage (series connection) | | 2.00 | V | I _F = 100 mA |
| | | | 2.50 | V | I _F = 200 mA |
| T _{RR} | Reverse Recovery Time | | 50 | nS | I _F = I _R = 30 mA I _{RR} = 3.0 mA R _L = 100 ohms |

NOTES:

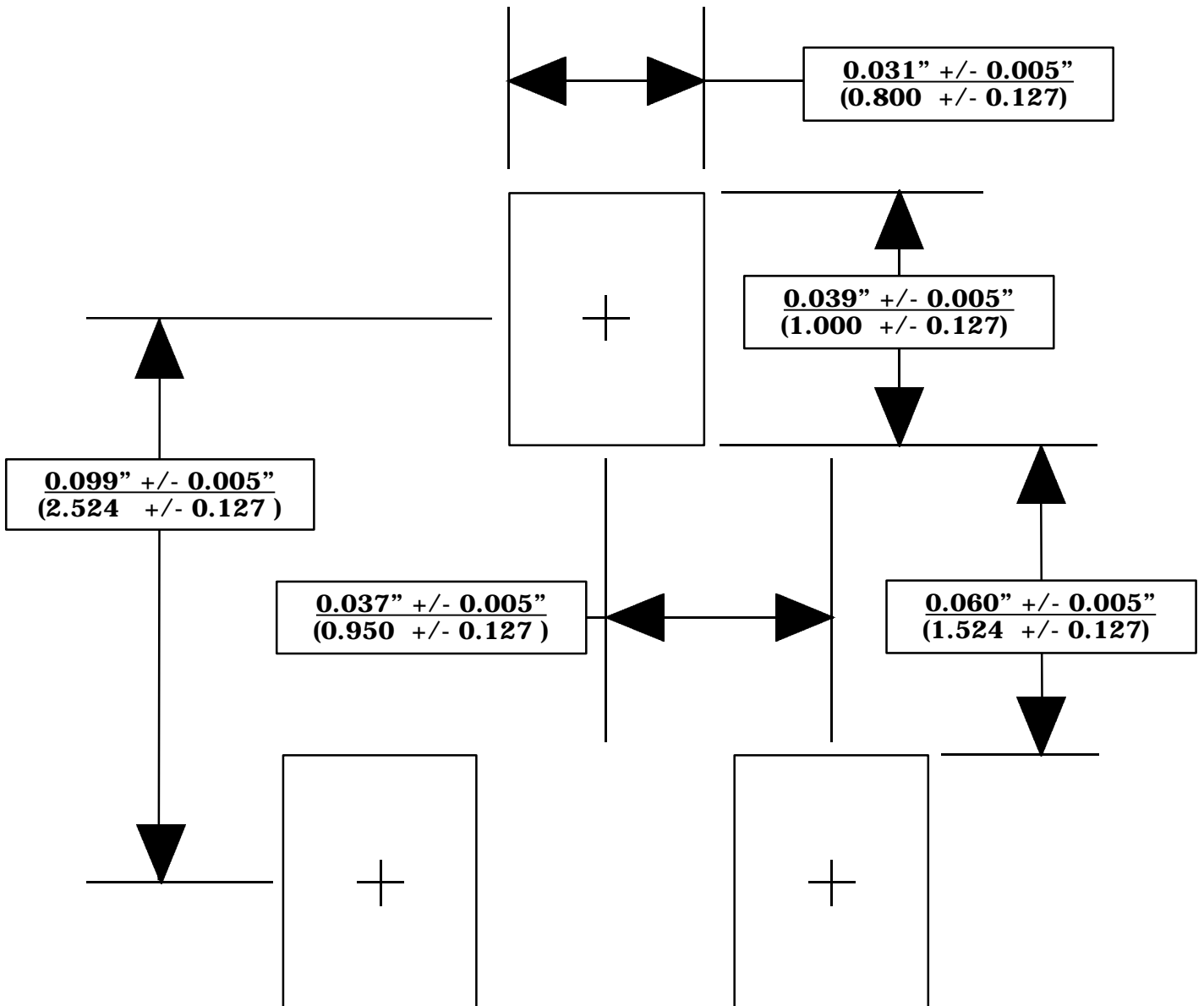
1. These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.
2. These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
3. These ratings give a maximum junction temperature of 150 degrees C and junction-to-ambient thermal resistance of 357 degrees C per Watt. (Derating factor of 2.8 milliwatts per degree C)



SOT-23
TO-236AB (LOW PROFILE)
22-August-1994



**RECOMMENDED SOLDER PADS
FOR
SOT-23**



**RECOMMENDED SOLDER PADS
FOR
U.S. & European SOT-23
&
Japanese SC-59**

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| FACT™ | QS™ |
| FACT Quiet Series™ | Quiet Series™ |
| FAST® | SuperSOT™-3 |
| FASTr™ | SuperSOT™-6 |
| GTO™ | SuperSOT™-8 |
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|--------------------------|------------------------|---|
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